

<b>Notice of References Cited</b>	Application/Control No. 10/782,861	Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner Nitin Patel	Art Unit 2629	Page 1 of 1

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*	B	US-6,583,776	06-2003	Yamazaki et al.	345/77
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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